

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
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Examiner		Art Unit		Page 1 of 1
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**NON-PATENT DOCUMENTS**

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	U	Hamscher et al., Extensible Business Reporting Language (XBRL) Specification, July 31, 2000, XBRL Organization, pages 1-27.
	V	Berkeley et al., The Road to Better Business Information Making a Case for XBRL, Winter 2000, Microsoft, pages 1-13.
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.